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APPLICANT'S ART CITATION (Use several sheets if necessary)		Application		OEFS File No. P/25-267 #8	
		Applicant Donald Dominic ARNONE et al.			
		Filing Date		Group Art Unit	

U.S. PATENT DOCUMENTS												
Examiner Initial	Document Number							Date	Name	Class	Sub-class	Filing Date If Appropriate

FOREIGN PATENT DOCUMENTS													
	Document Number							Date	Country	Class	Sub-class	Translation	
												Yes	No
	0	8	4	1	5	4	8	05/13/98	Europe				
	0	8	2	8	1	4	3	03/11/98	Europe				
	0	7	2	7	6	7	1	08/21/96	Europe				
	0	8	6	4	8	5	7	09/16/98	Europe				
	2	2	5	4	4	1	7	10/07/92	Great Britain				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	
	WU Q ET AL: "TWO-DIMENSIONAL ELECTRO-OPTIC IMAGING OF THZ BEAMS" APPLIED PHYSICS LETTERS, US, AMERICAN INSTITUTE OF PHYSICS. NEW YORK
	vol. 69, no. 8, 19 August 1996 (1996-08-19), pages 1026-1028, XP000626128 ISSN: 0003-6951
	PATENT ABSTRACTS OF JAPAN
	vol. 13, no. 182 (C-591), 27 April 1989 (1989-04-27)
	& JP 01 011530 A (HITACHI), 17 January 1989 (1989-01-17)
	Abstract

Examiner	Date Considered
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